


<b>Search Notes</b> 	<b>Application/Control No.</b> 10822310	<b>Applicant(s)/Patent Under Reexamination</b> LAVOIE ET AL.
	<b>Examiner</b> RACHNA S DESAI	<b>Art Unit</b> 2176

SEARCHED			
Class	Subclass	Date	Examiner
715	212, 227, 229	10/10/08	RSD

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (USPAT; USPGPUB; EPO; JPO; DERWENT; IBM-TDB) - Search Notes Attached	10/10/08	RSD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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